TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7SH02FE

2 Input NOR Gate

Features

• Super high speed operation :tpD = 3.6 ns (typ.)

 $@V_{CC} = 5 \text{ V}$

• Low power dissipation : $I_{CC} = 2 \mu A$ (Max.)

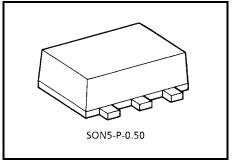
@ Ta = 25°C

• High noise immunity : $V_{NIH} = V_{NIH}$

= 28% VCC (Min.)

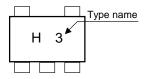
• 5.5V tolerant input.

• Wide operation voltage range : V_{CC} (opr) = 2~5.5 V

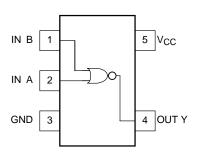


Weight: 0.003 g (typ.)

Marking



Pin Assignment (top view)



Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Supply voltage range	Vcc	-0.5~7	V
DC input voltage	V _{IN}	-0.5~7	V
DC output voltage	Vout	-0.5~V _{CC} + 0.5	V
Input diode current	lık	-20	mA
Output diode current	lok	±20	mA
DC output current	lout	±25	mA
DC V _{CC} /ground current	Icc	±50	mA
Power dissipation	P _D	150	mW
Storage temperature	T _{stg}	-65~150	°C

Logic Diagram

IN A _______ > 1 ______ OUT Y

Truth Table

Α	В	Υ
L	L	Н
٦	Н	L
I	L	L
I	Ι	L

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit			
Supply voltage	Vcc	2~5.5	V			
Input voltage	V _{IN}	0~5.5	V			
Output voltage	V _{OUT}	0~ V _{CC}	V			
Operating temperature	T _{opr}	-40~85	°C			
Input rise and fall time	dt/dv	0~100 (V_{CC} = 3.3 V ± 0.3 V)	ns/V			
input rise and rail time	αι/αν	0~20 (V_{CC} = 5 V ± 0.5 V)	115/ V			

Electrical Characteristics

DC Characteristics

Characteristics Symbol Test Circuit		Test	Test Condition			Ta = 25°C Ta = $-40\sim85$ °C			0~85°C	Unit	
		lest Condition		V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit	
High-level input voltage					2.0	1.5	_	_	1.5	_	
			3.0		V _{CC} × 0.7	_	_	V _{CC} × 0.7	_	V	
Low-level input					2.0	_		0.5	_	0.5	V
voltage	V _{IL}			_	3.0~5.5	_	_	V _{CC} × 0.3	_	V _{CC} × 0.3	
				I _{OH} = -50 μA	2.0	1.9	2.0	_	1.9	_	-
					3.0	2.9	3.0	_	2.9	_	
High-level VOH	_	$V_{IN} = V_{IL} \\$		4.5	4.4	4.5	_	4.4	_	V	
				$I_{OH} = -4 \text{ mA}$	3.0	2.58	_	_	2.48	_	
				$I_{OH} = -8 \text{ mA}$	4.5	3.94	_	_	3.80	_	
Low-level output voltage		V _{IN} = V _{IH} or V _{II}	$I_{OL} = 50 \mu A$ $I_{OL} = 4 \text{ mA}$	2.0	_	0	0.1	_	0.1	٧	
				3.0	_	0	0.1	_	0.1		
	_			4.5	_	0	0.1	_	0.1		
				3.0	_	_	0.36	_	0.44		
			$I_{OL} = 8 \text{ mA}$	4.5	_		0.36	_	0.44		
Input leakage current	I _{IN}	_	V _{IN} = 5.5 V or GND		0~5.5	_	_	±0.1	_	±1.0	μА
Quiescent supply current	Icc	_	V _{IN} = V _{CC} or GND		5.5	_		2.0	_	20.0	μА

AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = -40~85°C		Unit
	Symbol	Vcc	; (V)	C _{L (} pF)	Min	Тур.	Max	Min	Max	Offic
Propagation delay time	^t PLH ^t PHL	3.3 ± 0.3	15	-	5.6	7.9	1.0	9.5	ns	
		3.3 ± 0.3		50	_	8.1	11.4	1.0		13.0
		5.0 ± 0.5	15	_	3.6	5.5	1.0	6.5		
			E U.5	50	_	5.1	7.5	1.0	8.5	
Input capacitance	C _{IN}				_	4	10	_	10	pF
Power dissipation capacitance	C _{PD}	(Note)			_	15	_	_	_	pF

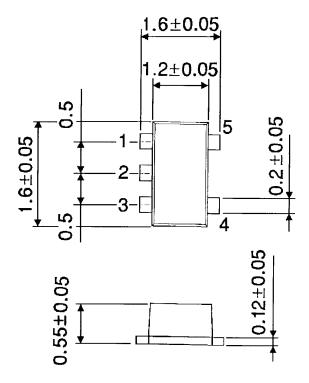
Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation.

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

Package Dimensions

SON5-P-0.50 Unit: mm



Weight: 0.003 g (typ.)

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